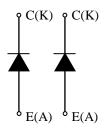
## M1200H45E2

#### **FEATURES**

- \* Low VF diode module.
- \* Low noise recovery: Ultra soft fast recovery diode.
- \* High reverse recovery capability: Super HiRC Structure.
- \* High reliability, high durability diodes.
- \* Isolated heat sink (terminal to base).

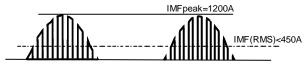
#### **CIRCUIT DIAGRAM**



### **ABSOLUTE MAXIMUM RATINGS (TC=25°C)**

Item			Symbol	Unit	MDM1200H45E2		
Repetitive Peak Reverse Voltage			$V_{RRM}$	V	4,500		
Forward Current		AC peak	<b>I</b> MFpeak	Α	1,200		
	-	1ms	I <sub>Fpulse</sub>	Λ.	2,400		
Junction Temperature			Tj	ပွ	-40 ∼ +125		
Storage Temperature			Tstg	°C	-50 ∼ +125 (1)		
Isolation Test	on Test Terminals-base		V <sub>ISO</sub>	V <sub>RMS</sub>	8,400 (AC 1 minute)		
Voltage	Terminal 1-Terminal 2		$V_{ISOT-T}$	VRMS	8,400 (AC 1 minute)		
Screw Torque	Terminals (M8)		-	N∙m	10 (2)		
	Mounting	Mounting (M6)		111.111	6 (3)		

Notes: (1) Terminal temperature shall not exceed the specified temperature in any operation. (2) Recommended Value 9±1N·m (3) Recommended Value 5.5±0.5N·m



#### **ELECTRICAL CHARECTERISTICS**

Item	Symbol	Unit	Min.	Тур.	Max.	Test Conditions
Repetitive Reverse Current	I <sub>RRM</sub>	mΑ	-	2.0	25	VAK=4,500V, Tj=125°C
Forward Voltage Drop	$V_{F}$	V	-	3.4	3.9	IF=1,200A, Tj=125°C
Reverse Recovery Time	trr	μS	1	0.9	1.8	Vcc=2,600V, IF=1,200A, Ls=180nH
Reverse Recovery Loss	E <sub>rr(10%)</sub>	J/P	ı	3.4	5.1	Tj=125°C Rg=3.3 Ω (4)

Notes:(4) Counter arm; MBN1200H45E2 VGE=+/-15V

Rg value is the test condition's value for evaluation of the switching times, not recommended value. Please, determine the suitable Rg value after the measurement of switching waveforms

(overshoot voltage, etc.) with appliance mounted.

#### PACKAGE CHARECTERISTICS

Item	Symbol	Unit	Min.	Тур.	Max.	Test Conditions	
Terminal Resistance	Rce	$m\Omega$	-	0.3	-	per arm	
Terminal Stray Inductance	Lsce	nΗ	-	42	-	per arm	
Thermal Impedance	Rth(j-c)	K/W	-	-	0.017	Junction to case (per arm)	
Comparative tracking index	CTI		-	600	-		
Contact Thermal Impedance	Rth(c-f)	K/W	-	0.007	-	Case to fin (λgrease=1W/(m⋅K), heat-sink flatness ≤50um)	

<sup>\*</sup> Please contact our representatives at order.



<sup>\*</sup> For improvement, specifications are subject to change without notice.

<sup>\*</sup> For actual application, please confirm this spec sheet is the newest revision.

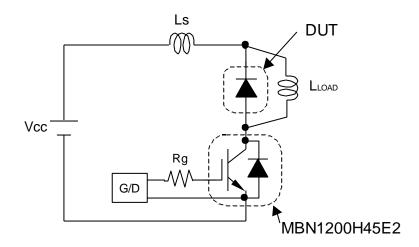


Fig.1 Switching test circuit

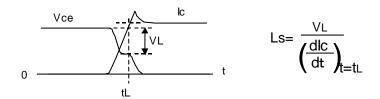


Fig.2 Definition of stray inductance

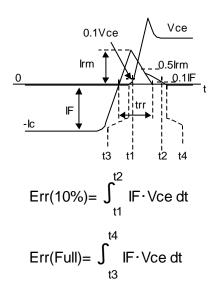
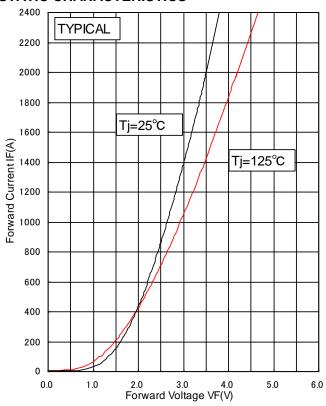


Fig.3 Definition of switching loss

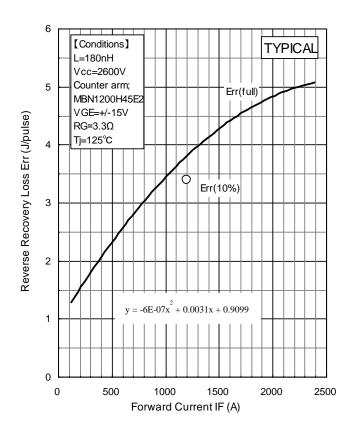


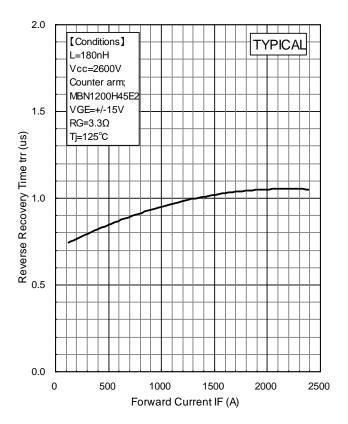
### STATIC CHARACTERISTICS



Forward Voltage of diode

### **DYNAMIC CHARACTERISTICS**

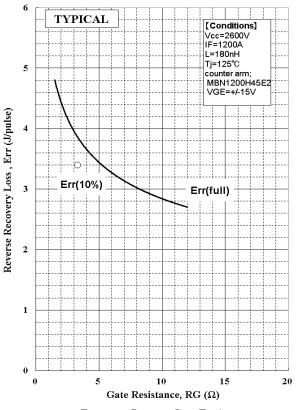


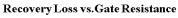


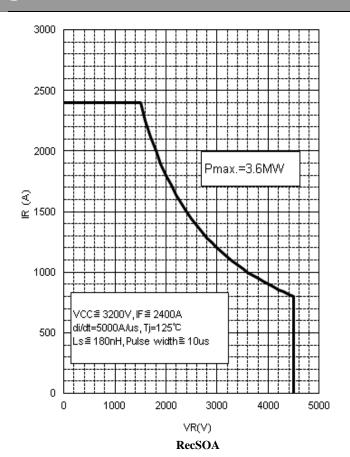
**Recovery Loss vs. Forward Current** 

**Recovery Time vs. Forward Current** 

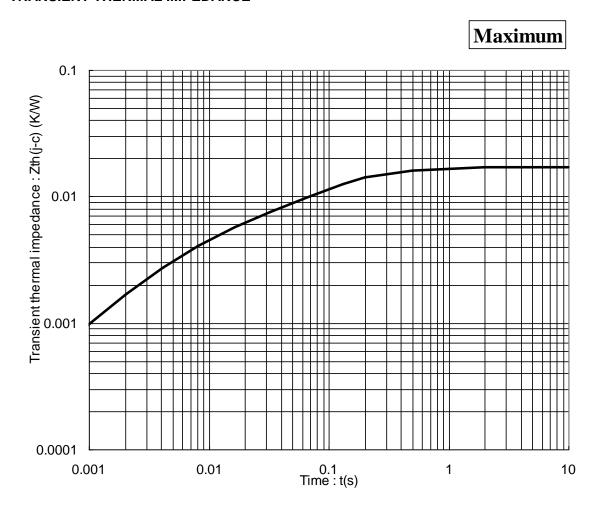








### TRANSIENT THERMAL IMPEDANCE



### **Transient Thermal Impedance Curve**

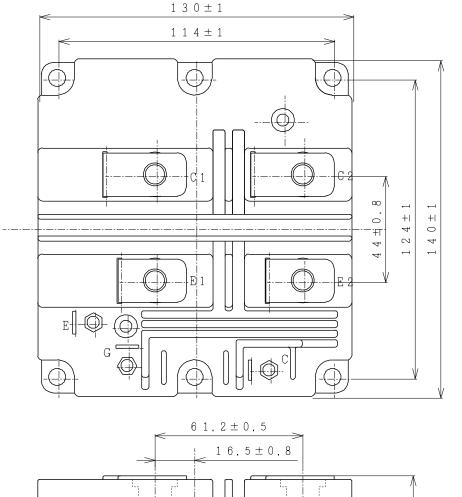
### Curve Approximation Model Σ rth[n]\*(1-exp(-t/τth[n]))

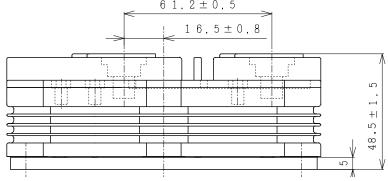
n	1	2	3	4	Unit
τ th[n]	3.98E-01	6.81E-02	1.32E-02	3.16E-04	sec
rth[n,IGBT]	1.02E-02	3.35E-03	3.19E-03	2.87E-04	K/W



### **OUTLINE DRAWING**

Unit in mm





Weight: 1050(g)

### **Material declaration**

Please note the following materials are contained in the product in order to keep product characteristic and reliability level.

Material	Contained part
Lead (Pb) and its compounds	Solder



### HITACHI POWER SEMICONDUCTORS

### Notices

- 1. The information given herein, including the specifications and dimensions, is subject to change without prior notice to improve product characteristics. Before ordering, purchasers are advised to contact Hitachi sales department for the latest version of this data sheets.
- 2. Please be sure to read "Precautions for Safe Use and Notices" in the individual brochure before use.
- 3. In cases where extremely high reliability is required(such as use in nuclear power control, aerospace and aviation, traffic equipment, life-support-related medical equipment, fuel control equipment and various kinds of safety equipment), safety should be ensured by using semiconductor devices that feature assured safety or by means of users' fail-safe precautions or other arrangement. Or consult Hitachi's sales department staff.
- 4. In no event shall Hitachi be liable for any damages that may result from an accident or any other cause during operation of the user's units according to this data sheets. Hitachi assumes no responsibility for any intellectual property claims or any other problems that may result from applications of information, products or circuits described in this data sheets.
- 5. In no event shall Hitachi be liable for any failure in a semiconductor device or any secondary damage resulting from use at a value exceeding the absolute maximum rating.
- 6. No license is granted by this data sheets under any patents or other rights of any third party or Hitachi, Ltd.
- 7. This data sheets may not be reproduced or duplicated, in any form, in whole or in part, without the expressed written permission of Hitachi, Ltd.
- 8. The products (technologies) described in this data sheets are not to be provided to any party whose purpose in their application will hinder maintenance of international peace and safety not are they to be applied to that purpose by their direct purchasers or any third party. When exporting these products (technologies), the necessary procedures are to be taken in accordance with related laws and regulations.
- For inquiries relating to the products, please contact nearest overseas representatives which is located "Inquiry" portion on the top page of a home page.

Hitachi power semiconductor home page address http://www.hitachi.co.jp/products/power/pse/

